

## 16A, 100V N-CHANNEL MOSFET

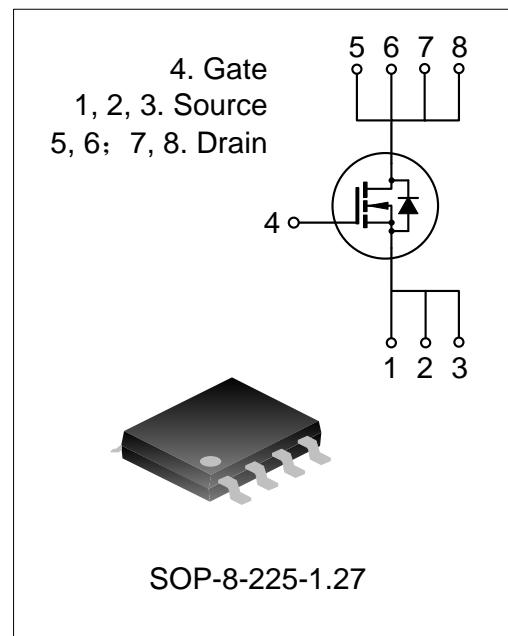
### DESCRIPTION

SVG10120NSA is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan's LVMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance.

This device is widely used in power management for UPS and Inverter Systems.

### FEATURES

- 16A, 100V,  $R_{DS(on)(typ.)}=10m\Omega$ @ $V_{GS}=10V$
- Low gate charge
- Low Crss
- Fast switching
- Improved dv/dt capability



### ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SVG10120NSA	SOP-8-225-1.27	10120NSA	Halogen free	Tube
SVG10120NSATR	SOP-8-225-1.27	10120NSA	Halogen free	Tape&Reel

### ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, $T_c=25^\circ C$ )

Characteristics		Symbol	Ratings		Unit
Drain-Source Voltage		$V_{DS}$	100		V
Gate-Source Voltage		$V_{GS}$	$\pm 20$		V
Drain Current	$T_c=25^\circ C$	$I_D$	16		A
	$T_c=100^\circ C$		10		
Drain Current Pulsed		$I_{DM}$	64		A
Power Dissipation ( $T_c=25^\circ C$ ) -Derate above 25°C		$P_D$	6.3		W
			0.05		
Single Pulsed Avalanche Energy (Note 1)		$E_{AS}$	157		mJ
Operation Junction Temperature Range		$T_J$	-55~+150		°C
Storage Temperature Range		$T_{stg}$	-55~+150		°C

## THERMAL CHARACTERISTICS

Characteristics	Symbol	Ratings	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	20	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	85	°C/W

## ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED, $T_c=25^\circ C$ )

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	100	--	--	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=100V, V_{GS}=0V$	--	--	1.0	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.4	--	2.4	V
Static Drain- Source On State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=11.5A$	--	10	12	$m\Omega$
		$V_{GS}=4.5V, I_D=9.5A$	--	12.5	15.5	$m\Omega$
Gate Resistance	$R_G$	$f=1MHz$	--	1.8	--	$\Omega$
Input Capacitance	$C_{iss}$	$f=1MHz, V_{GS}=0V, V_{DS}=50V$	--	3211	--	$pF$
Output Capacitance	$C_{oss}$		--	348	--	
Reverse Transfer Capacitance	$C_{rss}$		--	6.0	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=50V, V_{GS}=10V, R_G=3\Omega, I_D=11.5A$ (Notes 2,3)	--	17	--	ns
Turn-on Rise Time	$t_r$		--	40	--	
Turn-off Delay Time	$t_{d(off)}$		--	48	--	
Turn-off Fall Time	$t_f$		--	12	--	
Total Gate Charge	$Q_g$	$V_{DD}=80V, V_{GS}=10V, I_D=11.5A$ (Notes 2,3)	--	46	--	nC
Gate-Source Charge	$Q_{gs}$		--	13	--	
Gate-Drain Charge	$Q_{gd}$		--	5.9	--	

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

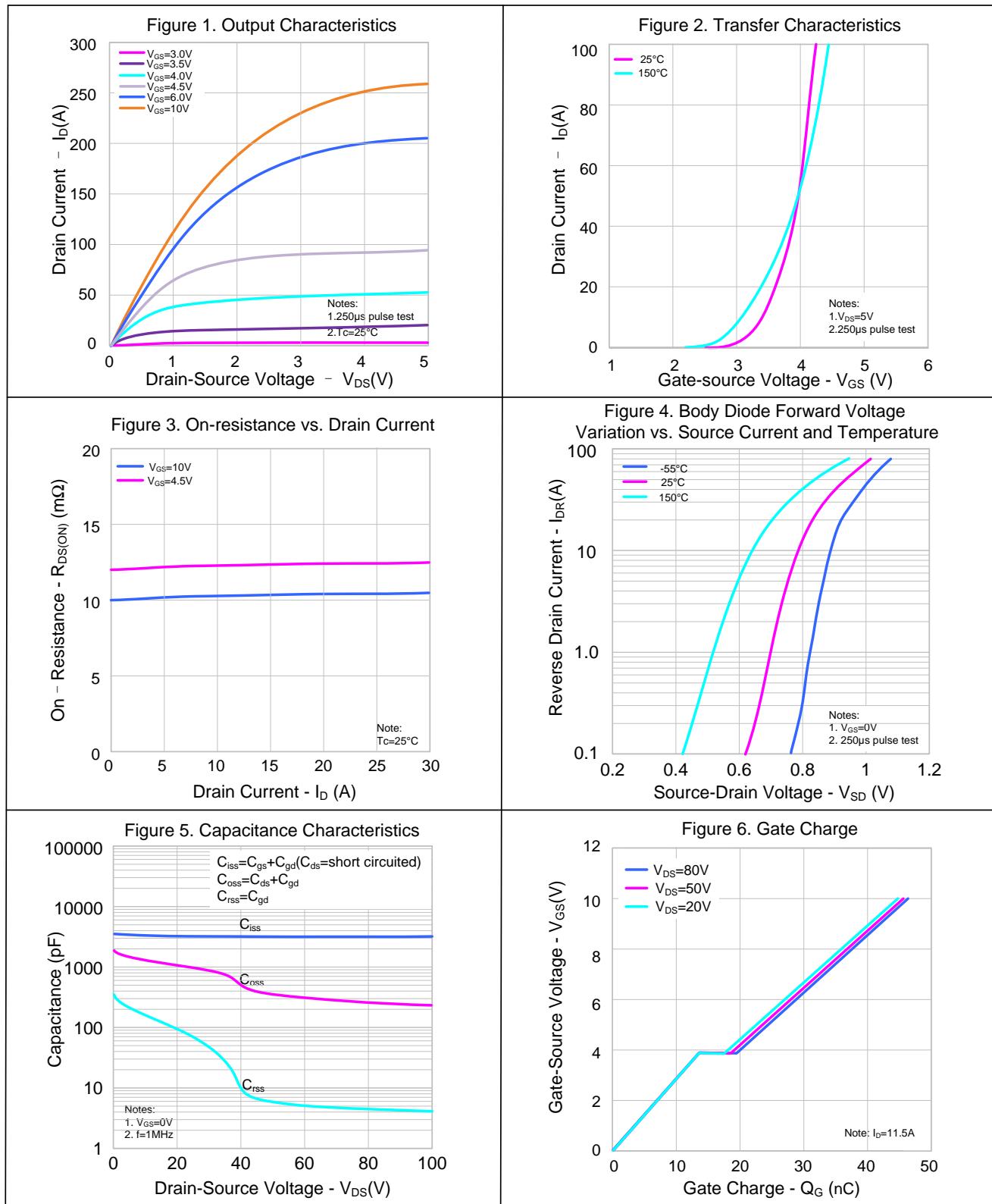
Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	16	A
Pulsed Source Current	$I_{SM}$		--	--	64	
Diode Forward Voltage	$V_{SD}$	$I_S=11.5A, V_{GS}=0V$	--	--	1.4	V
Reverse Recovery Time	$T_{rr}$	$I_S=11.5A, V_{GS}=0V, dI/dt=100A/\mu s$ (Note 2)	--	86	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	0.14	--	$\mu C$

### Notes:

1.  $L=0.5mH, I_{AS}=25A, V_{DD}=50V, R_G=10\Omega$ , starting  $T_J=25^\circ C$ ;
2. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ ;
3. Essentially independent of operating temperature.



## TYPICAL CHARACTERISTICS





## TYPICAL CHARACTERISTICS (CONTINUED)

Figure 7. Breakdown Voltage Variation vs. Temperature

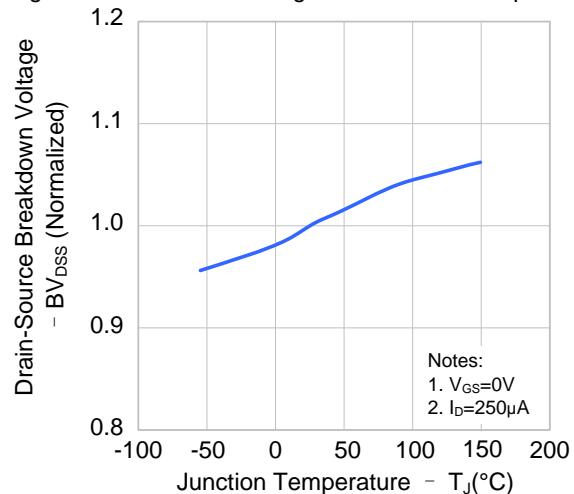


Figure 8. On-resistance Variation vs. Temperature

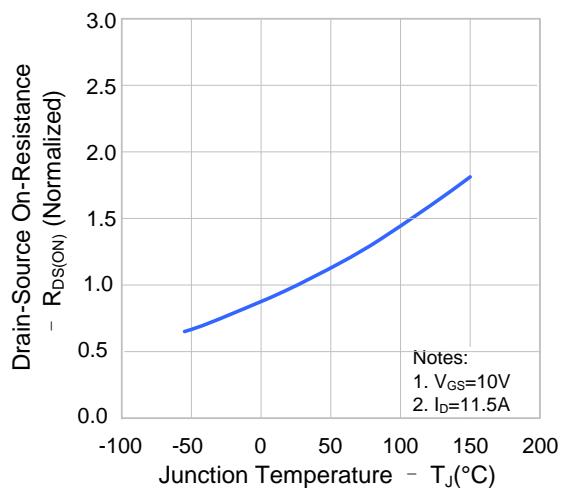
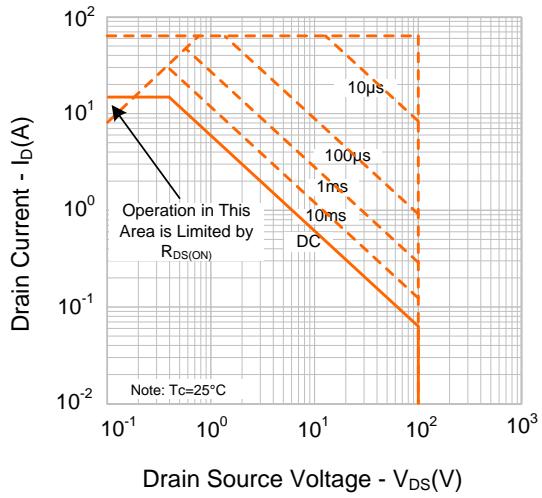


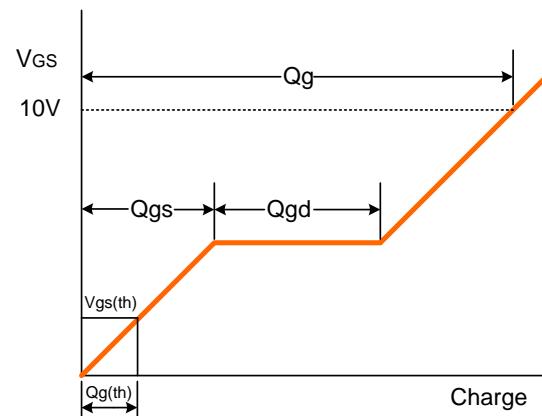
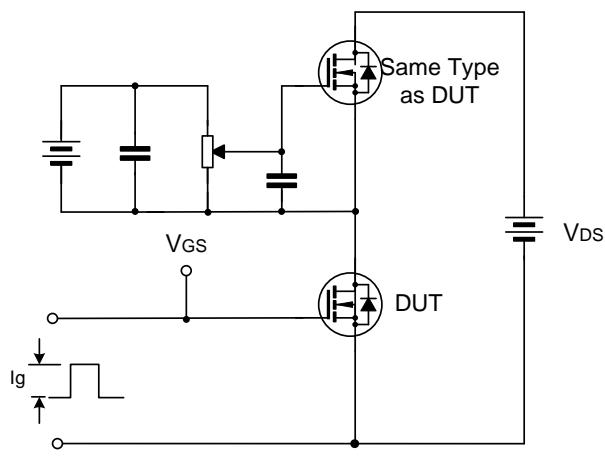
Figure 9. Max. Safe Operating Area



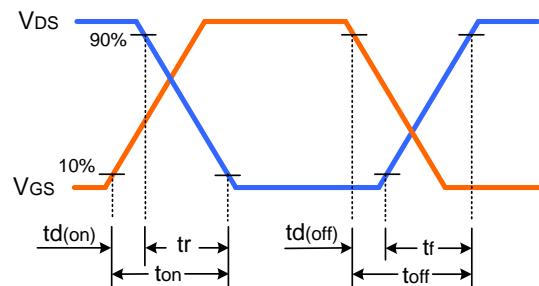
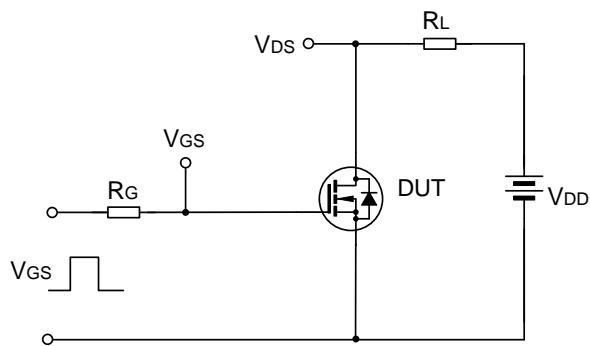


## TYPICAL TEST CIRCUIT

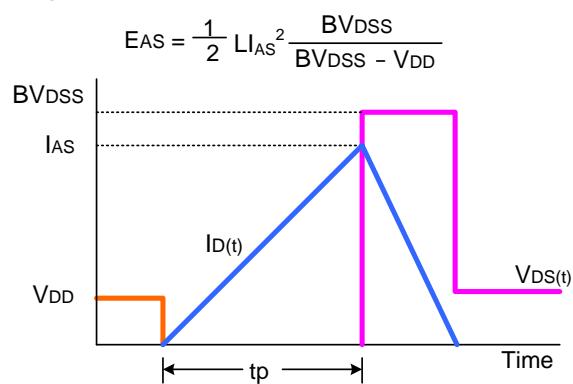
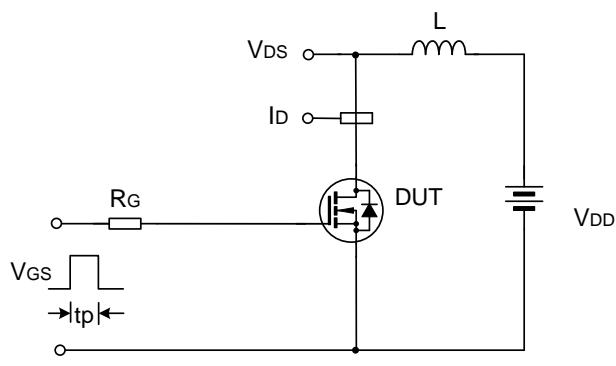
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



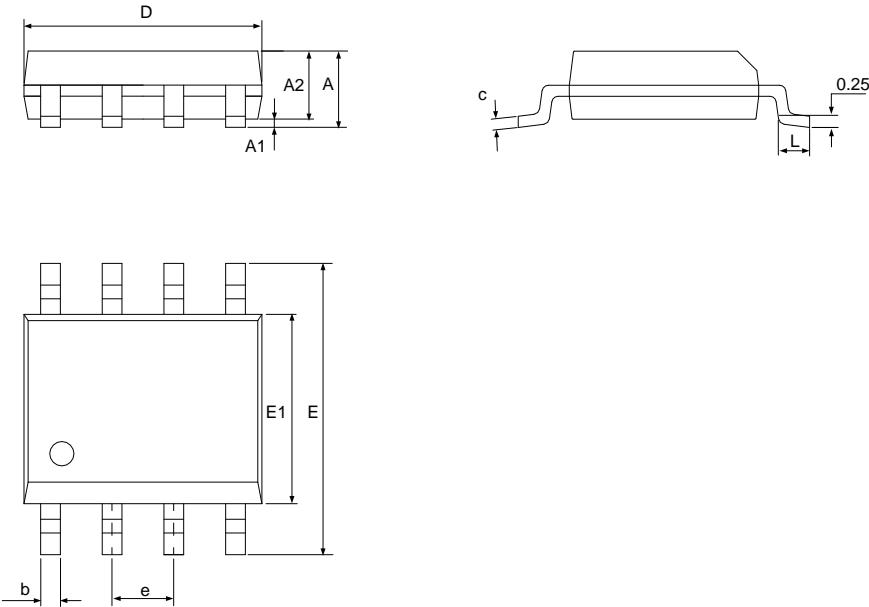
Unclamped Inductive Switching Test Circuit & Waveform





## PACKAGE OUTLINE

SOP-8-225-1.27		UNIT: mm		
SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
A	1.35	1.55	1.75	
A1	0.05	0.15	0.25	
A2	1.25	—	1.65	
b	0.32	0.42	0.52	
c	0.15	0.20	0.26	
D	4.70	4.90	5.30	
E	5.60	6.00	6.40	
E1	3.60	3.90	4.20	
e	1.27BSC			
L	0.30	—	1.27	



### Important notice :

1. The instructions are subject to change without notice!
2. Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current. Please read the instructions carefully before using our products, including the circuit operation precautions.
3. Our products are consumer electronic products or the other civil electronic products.
4. When using our products, please do not exceed the maximum rating of the products, otherwise the reliability of the whole machine will be affected. There is a certain possibility of failure or malfunction of any semiconductor product under specific conditions. The buyer is responsible for complying with safety standards and taking safety measures when using our products for system design, sample and whole machine manufacturing, so as to avoid potential failure risk that may cause personal injury or property loss.
5. It is strongly recommended to identify the trademark when buying our products. Please contact us if there is any question.
6. Product promotion is endless, our company will wholeheartedly provide customers with better products!
7. Website: <http://www.silan.com.cn>

---

Part No.: **SVG10120NSA** Document Type: **Datasheet**  
Copyright: **HANGZHOU SILAN MICROELECTRONICS CO.,LTD** Website: **<http://www.silan.com.cn>**

---

Rev.: **1.1**

Revision History:

1. Update SOA
- 

Rev.: **1.0**

Revision History:

1. First release
-